

CONTENTS

CHAPTER 1. INTRODUCTION.....	19
1.1. Introducing Crystallography	21
1.1.1. Single-Crystal X-Ray Diffraction (SCXRD)	22
1.1.2. Polycrystal X-Ray Diffraction (PXRD)	22
1.1.3. Neutron Diffraction.....	22
1.2. Electron Crystallography	23
1.2.1. Electron Diffraction	23
1.2.2. Transmission Electron Microscope.....	26
1.2.3. Beam Damage, Dynamical Diffraction, and Excitation Error.....	29
1.2.4. Zone axis ED patterns.....	32
1.2.5. Beam precession.....	32
1.3. Three-Dimensional Electron Diffraction Methods (3DED).....	34
1.3.1. Automated Electron Diffraction (ADT)	36
1.3.2. Precession Electron Diffraction Tomography (PEDT).....	37
1.3.3. Rotation Electron Diffraction (RED).....	38
1.3.4. Continuous Rotation Electron Diffraction (cRED) and Microelectron Diffraction (MicroED)	39
1.4. Quality Data Parameters	41
1.5. Key Parameters for Structure Model Refinement.....	42
1.6. Detectors and Data Collection Scripts	44
1.7. TEM Holders.....	46
1.8. What are zeolites?.....	47
1.8.1. Zeolites and Ordered Porous Solids	47
1.8.2. Structure of Zeolites	47
1.8.3. Synthesis, Heteroatoms Incorporation, and Structure Directing Agents.....	49
1.8.4. Application of 3DED Methods for Zeolite Structure Determination	51
CHAPTER 2. OBJECTIVES	55
CHAPTER 3. CHARACTERIZATION METHODS	59
3.1. Three-Dimensional Electron Diffraction (3DED).....	61
3.1.1. Grid Preparation and TEM Holders	61
3.1.2. Transmission Electron Microscopes and Detector System.....	62
3.1.3. Precession Equipment	65
3.1.4. cRED and PEDT Data Collection	66

3.1.5. cRED and PEDT Data Processing.....	68
3.1.6. Structure Solution and Refinement.....	68
3.2. Powder X-Ray Diffraction (PXRD)	69
3.3. Additional Characterization Techniques.....	69
3.3.1. Field-Emission Scanning Electron Microscopy (FESEM).....	70
3.3.2. Computational Methods.....	70
3.3.3. Elemental Analysis (EA)	71
3.3.4. Chemical Analysis	71
3.3.5. Thermogravimetric Analysis (TGA)	71
3.3.6. Liquid and Solid Nuclear Magnetic Resonance (NMR)	72
3.3.5.1. ^{19}F -NMR	73
3.3.5.2. ^{29}Si -NMR	74

CHAPTER 4. STRUCTURE DETERMINATION OF THE AS-MADE ZEOLITES ITQ-52

77

4.1. Synthesis, Chemical, Thermogravimetric, and Textural Analysis.....	79
4.2. PXRD Characterization	82
4.3. 3DED Characterization	83
4.3.1. Data Acquisition: JEOL 2100F TEM	84
4.3.2. Data Acquisition: JEOL 2100-LaB ₆ TEM.....	87
4.3.3. Data Acquisition: FEI TECNAI G2 TEM.....	90
4.4. Data Reduction and Framework Structure Solution	93
4.5. Location of the OSDA by Simulated Annealing	98
4.6. Kinematical and Dynamical Refinement from 3DED Data	100
4.7. Refinement against PXRD Data.....	103
4.8. Structural Comparison of OSDAs in C-ITQ-52 and N-ITQ-52	109

CHAPTER 5. STRUCTURE DETERMINATION OF THE AS-MADE ZEOLITE ITQ-70

113

5.1. Synthesis, Chemical, Thermogravimetric, and Textural Analysis.....	115
5.2. PXRD Characterization	125
5.3. 3DED Characterization	126
5.3.1. Data Acquisition: JEOL 2100F TEM	126
5.3.2. Data Acquisition: FEI TECNAI G2 TEM.....	127
5.4. Data Reduction and Framework Structure Solution	129
5.5. Location of OSDA by Simulated Annealing	135
5.6. Computational Method for OSDA Location.....	140
5.7. Refinement against Powder XRD Data	141
5.8. Structure Description	145

CHAPTER 6. STRUCTURE DETERMINATION OF AS-MADE ZEOLITE ITQ-35153

6.1. Synthesis, Chemical, Thermogravimetric, and Textural Analysis.....	155
6.2. PXRD Characterization	160
6.3. 3DED Characterization	161
6.3.1. Data Acquisition: FEI TECNAI G2 TEM.....	161
6.4. Data Reduction and Framework Structure Solution	166
6.5. Strategies for OSDA Location	170
6.5.1. Kinematical Refinement.....	170
6.5.2. Simulated Annealing	172
6.5.3. Computational Methods.....	178
6.6. Refinement against PXRD Data.....	180
6.7. Structure Description	183
CHAPTER 7. CONCLUSIONS.....	185

APPENDICES

Appendix I	189
Appendix II	195
Appendix III.....	213
List of Publications.....	215
Curriculum Vitae	217
References	219